## Application/Control No. Applicant(s)/Patent Under Reexamination 10/807,073 LIN ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 Mark A. Chapman 1756 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification MM-YYYY Country Code-Number-Kind Code US-2003/0211413 11-2003 Lin et al. 430/78 Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-US-K US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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